

Search Notes**Application/Control No.**

10/791,085

Examiner

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Applicant(s)/Patent under Reexamination

STEIGERWALD ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	562.1	1/24/2006	HN
	575.7		
	575.5		
	97		
	129		
	13.2		
	19		
	82		
343	851		
	702		
	789		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPAT, US-PGPUB, DERWENT, JPO, EPO). See search history printout	1/24/2006	HN
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	6/28/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner